

#8

Modified Form PTO/SB/08A

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				<i>Complete If Known</i>	
				Application Number	09/781,833
				Filing Date	February 12, 2001
				First Named Inventor	Eldridge et al.
				Group Art Unit	1765
				Examiner Name	A. Alanko
Sheet	1	of	2	Attorney Docket No.	276440-4

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TC 1700

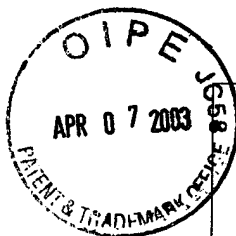
U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant	Publication Date	Relevant Portions
		Number	Kind Code ²			
ALA	1	H842		Ochs	11/6/1990	

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant	Publication Date	Relevant Portions	T ⁶
		Office ³	Number ⁴	Kind Code ⁵				
ALA	2	EP	632281		Pedder	1/4/1995		
	3	EP	899538		IMEC vzw	3/3/1999		
	4	JP	58-191453		Kazuo	11/8/1983		x
	5	JP	05-18741		Kawase et al.	1/26/1993		x
	6	JP	05-198716		Osawa	8/6/1993		x
	7	JP	06-267408		Todokoro et al.	9/22/1994		x
	8	JP	07-21968		Watanabe et al.	1/24/1995		x
	9	JP	07-333232		Canon Inc.	12/22/1995		x
	10	JP	08-306708		Harada	11/22/1996		x
	11	WO	91/12706		Leedy	8/22/1991		
	12	WO	96/16440		Khandros et al.	5/30/1996		
	13	WO	97/44676		FormFactor, Inc.	11/27/1997		
	14	WO	98/21597		Charmant et al.	5/22/1998		
	15	WO	98/52224		FormFactor, Inc.	11/19/1998		
	16	WO	99/38229		Kinetrix, Inc.	7/29/1999		
	17	WO	00/33089		FormFactor, Inc.	6/8/2000		
	18	WO	00/33096		Eldridge et al.	6/8/2000		
	19	WO	01/9952		Eldridge et al.	2/8/2001		

Examiner Signature	<i>Anita Alanko</i>	Date Considered	6/2/03
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.



Modified Form PTO/SB/08A

Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet 2 of 2

Complete If Known

Application Number	09/781,833
Filing Date	February 12, 2001
First Named Inventor	Eldridge et al.
Group Art Unit	1765
Examiner Name	A. Alanko
Attorney Docket No.	276440-4

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TC 1700**OTHER PRIOR ART - NONPATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ⁶
AAS ↓	20	"A New Wafer Probe Interface Technology Using Compliant Microsprings, A Joint Study by Teradyne, Inc. and FormFactor, Inc.," Teradyne Formfactor White Paper (Teradyne, Inc. and FormFactor, Inc., January 30, 1998), pp. 1-18	
	21	NOVITSKY et al., "FormFactor Introduces An Integrated Process For Wafer-Level Packaging, Burn-in Testing, And Module Level Assembly" (FormFactor, Inc., March 1999), 6 pages	
	22	KHANDROS et al., "New Methods For Reducing Costs In Semiconductor Back-End," (FormFactor, Inc., January 30, 1998), 9 pages	

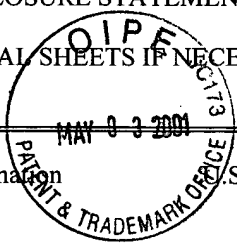
Examiner Signature	<i>Amita Alanko</i>	Date Considered	6/2/03
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

#5

FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 276440-4	SERIAL NO. 09/781,833
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANTS: Benjamin N. ELDRIDGE and Stuart W. WENZEL	
	FILING DATE: February 12, 2001	GROUP: 2812 1765



Reference Designation S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
<i>WJH</i>	AA 5,513,430	05/07/96	Yanof et al.		
<i>↓</i>	AB 5,944,537	08/31/99	Smith et al.		
	AC				
	AD				
	AE				
	AF				
	AG				
	AH				
	AI				
	AJ				
	AK				
	AL				

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FOREIGN PATENT DOCUMENTS

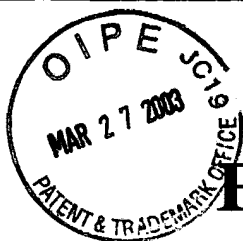
Document Number	Date	Country	Class	Filing Date Subclass if appropriate
AM				
AN				
AO				
AP				
AQ				

OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AR
AS
AT

EXAMINER *Aruta Alanko* DATE CONSIDERED *6/2/03*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Electronic Information Disclosure Statement

Method For Forming Microelectronic Spring Structures On A Substrate

Application: 
09/781833

Confirmation: 8560

Applicant(s): Benjamin Eldridge

Docket
Number: 276440-4











Group Art
Unit: 1765

Examiner: A. Alanko

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US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
	P01	3173737	1965-03-16		Kinkaid et al.		
	P02	3519890	1970-07-07		Ashby		
	P03	3842189	1974-10-15		Southgate		
	P04	4553192	1985-11-12		Babuka et al.		
	P05	4615573	1986-10-07		White et al.		

✓	P06	4772228	1998-09-20		Seymour
	P07	4893172	1990-01-09		Matsumoto et al.
	P08	5152695	1992-10-06		Grabbe et al.
	P09	5173055	1992-12-22		Grabbe
	P10	5210939	1993-05-18		Mallik et al.
	P11	5228861	1993-07-20		Grabbe
	P12	5286208	1994-02-15		Matsuoka
	P13	5462440	1995-10-31		Rothenberg
	P14	5534784	1996-07-09		Lum et al.
	P15	5555422	1996-09-10		Nakano
	P16	5576630	1996-11-19		Fujita
	P17	5599194	1997-02-04		Ozawa et al.
	P18	5613861	1997-03-25		Smith et al.
	P19	5632631	1997-05-27		Fjelstad et al.
	P20	5666190	1997-09-09		Quate et al.
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	P26	5974662	1999-11-02		Eldridge et al.
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	P30	6031282	2000-02-29		Jones et al.
	P31	6059982	2000-05-09		Palagonia et al.
	P32	6064213	2000-05-16		Khandros et al.
	P33	6072190	2000-06-06		Watanabe et al.
✓	P34	6183267	2001-02-06		Marcus et al.

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<input type="checkbox"/>	P36	6184576	2001-02-06		Jones et al.
<input type="checkbox"/>	P37	6214631	2001-04-10		Burrows et al.
<input type="checkbox"/>	P38	6255126	2001-07-03		Mathieu et al.
<input type="checkbox"/>	P39	6255727	2001-07-03		Khoury
<input type="checkbox"/>	P40	6289583	2001-09-18		Belmont et al.
<input type="checkbox"/>	P41	6307392	2001-10-23		Soejima et al.
<input type="checkbox"/>	P42	6344752	2002-02-05		Hagihara et al.
<input type="checkbox"/>	P43	6359455	2002-03-19		Takekoshi
<input checked="" type="checkbox"/>	P44	6452407	2002-09-17		Khoury et al.

Signature

Examiner Name	Date
<i>Anita Hancock</i>	<i>6/2/03</i>